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Design and Simulation of Continuously Tunable Multiband Terahertz Metamaterials

Xiaoqing Zhao, Bin Yang*, Jingquan Liu, Gang Tang¹ and Chunsheng Yang

National Key Laboratory of Science and Technology on Micro/Nano Fabrication,
Department of Micro/Nano Electronics, Shanghai Jiao Tong University,
800 Dongchuan Road, Minhang District, Shanghai 200240, China

Department of Mechanical Electrical Engineering, Nanchang Institute of Technology,
289 Tianxiang Avenue, Changdong Town, Nanchang County, Nanchang City,
Jiangxi Province 330099, China

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In this work, two types of metamaterial based on four symmetrical arc-shaped and line-shaped "T" cantilevers are investigated as resonator arrays, which can be structurally reconfigured by a thermal actuation mechanism. The simulation results show that both of the proposed metamaterial structures provide not only a resonant multiband-frequency operation but also polarization-independent tunability. The three resonance frequencies can be continuously adjusted in the range from 0.5000 to 2.5000 THz when the angles between the released cantilevers and the silicon substrate are changed at different temperatures. By investigating the electric and magnetic field strength distributions at the resonant frequencies, we have concluded that the multiband absorptions are caused by dipole-type resonance mechanisms. Our proposed tunable metamaterials have some advantages, namely, simple resonant structure, mechanism, and multiband operation frequencies in a narrow frequency range; these are highly desirable for THz applications in high-sensitivity sensing, tunable filtering, switching, frequency-selective detection, and multispectral imaging.

1. Introduction

The terahertz (THz) region has attracted much research interest for the realization of promising and conventionally unattainable applications owing to the several unique properties of THz waves; applications include invisibility cloaking devices, high-resolution superlenses, perfect absorbers, sensors, filters, nondestructive testing, and toroid responses. However, because naturally existing materials fall short of an

^{*}Corresponding author: e-mail: binyang@sjtu.edu.cn

appropriate response at some available frequencies, there are critical limitations to many practical applications in the THz field. Therefore, artificially structured electromagnetic materials have been widely studied for creating novel electromagnetic properties that are not available in natural materials, such as negative refractive index,⁽⁸⁾ perfect focusing,⁽⁹⁾ cloaking,⁽¹⁰⁾ polarization manipulation,⁽¹¹⁾ and phase discontinuities.⁽¹²⁾ These extreme electromagnetic properties are obtained through the interaction of incident electromagnetic waves with metamaterial structures, which are designed with different shapes and sizes. As a result, the interaction of the incident electromagnetic waves can be actively controlled as the metamaterial pattern shape is changed through external force actuation. These actuation mechanisms include optical,⁽¹³⁾ mechanical,⁽¹⁴⁾ electrical,⁽¹⁵⁾ magnetic,⁽¹⁶⁾ and thermal⁽¹⁷⁾ methods.

Recently, the tunability of metamaterials has received increasing attention, because the active control of metamaterial characteristics would enable their properties to be engineered in a desired way. It was suggested that the approach to metamaterial tunability has been demonstrated, for example, by semiconductor diodes⁽¹⁸⁾ to vary the capacitance of resonator media or photoexcitation,⁽¹⁹⁾ external voltages,⁽²⁰⁾ electrostatic actuation,⁽²¹⁾ external magnetostatic fields,⁽²²⁾ or thermal bimorphs⁽²³⁾ to change the property of surrounding media,⁽¹⁹⁾ and flexible substrates to achieve continuous deformation.⁽²⁴⁾ Structural tunability is an efficient way of controlling amplitude, polarization, or directionality for metamaterial structures so that metamaterial properties can be directly modified by reconfiguring the unit cell. Metamaterials with multiple-resonance excitations have provided access to unique and potential devices.

In this study, two structural multiband metamaterials with bimorph cantilevers were designed and simulated: micro-electromechanical system (MEMS)-based four symmetrical arc-shaped and line-shaped "T" cantilevers, respectively. The proposed MEMS-based metamaterial structures are geometrically reconfigurable and can be easily scaled by thermally reconfiguring the metamaterial unit cells. Furthermore, the upward-bending bimorph cantilevers can result in out-of-plane tunable deformation without the need for complicated fabrication processes. Using the thermal actuation mechanism, the bending degree of the MEMS-based bimorph cantilevers can be dynamically adjusted to achieve a tunable electromagnetic response in metamaterials.

2. Structural Design and Simulation

2.1 Structural design

In this study, two new types of metamaterial structure are proposed by changing the edge shape of the "T" cantilevers, which are composed of parylene-C bottom and gold top layers. These two modified metamaterial structures on a silicon substrate are expected to exhibit tunable multiband transmission characteristics. To simplify the expression, the arc-shaped and line-shaped "T" cantilever split ring resonator (SRR) structures are referred as T-SRR01 and T-SRR02, which are shown schematically in Figs. 1(a) and 1(b), respectively. The detailed dimensions of T-SRR01 and T-RR02 are shown in Table 1. The adjustable angle between the released cantilever tip and the substrate is expressed by "O". The capacitance of the T-SRR structures depends on the deformation

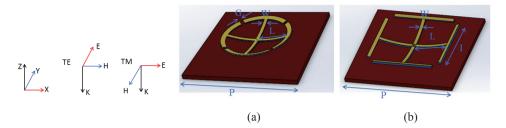


Fig. 1. (Color online) Schematic of the released unit cells for (a) T-SRR01 and (b) T-SRR02 arrays.

Table 1 Structural parameters of the T-SRRs.

| Device | Length L (μm) | Beam width W (µm) | Split wall width <i>I</i> (µm) | Split gap width <i>G</i> (µm) | Period P (μm) | Parylene-C thickness (µm) | Gold thickness (µm) |
|---------|---------------|-------------------|--------------------------------|-------------------------------|---------------|---------------------------------|---------------------|
| T-SRR01 | 40 | 4 | _ | 4 | 130 | 2 | 0.5 |
| T-SRR02 | 40 | 4 | 72 | _ | 130 | 2 | 0.5 |

angle of the cantilevers. Currently, the most reported MEMS-based metamaterials are actuated by electrical methods. However, for our designed structures, the anchor of the cantilever is located in the center. Hence, the thermal actuation mechanism is selected to adjust the deformation angle. Figures 1(a) and (b) show the released unit cells of the T-SRRs, which are bent upward due to the tensile stress of the cantilever. The incident electric fields for transverse electric (TE) and transverse magnetic (TM) polarizations are perpendicular and parallel to the *x*-axis, respectively, as shown in Fig. 1.

2.2 Electromagnetic simulation

Finite-difference time-domain (FDTD) numerical simulations were conducted to calculate the transmission spectra and the electromagnetic field distributions corresponding to the resonance modes with normally incident THz waves of either TE or TM polarization using Computer Simulation Technology (CST) software. Full-field electromagnetic wave simulations were performed with built-in material parameters (Au, Si, and user-defined parylene-C) from the software's material data. Parylene C film is a transparent polymer film, which has excellent electrical and chemical inertness, conformal coating, barrier, and physical properties, and good biocompatibility. It has been used in biomedical devices and microelectronics. Therefore, parylene-C was selected as the insulating dielectric layer in this work. The material parameters of Au, Si, and user-defined parylene-C are listed in Table 2. In the simulation, a single unit cell of the metamaterial was simulated under periodic boundary conditions employed in axial directions orthogonal to the incident waves. The perfectly matched layers are applied in

Au

14.2

0.4

| Waterial properties of simulated structures. | | | | | | | |
|----------------------------------------------|--------------|--------------|-----------------------------|-----------------|-----------------------------------------------------------------------|--|--|
| Materials | Permittivity | Permeability | Young's modulus (GPa) | Poisson's ratio | Coefficient of thermal expansion (×10 ⁻⁶ K ⁻¹) | | |
| Si | 11.9 | 1 | 169 | 0.3 | 2.568 | | |
| Parylene-C | 2.9 | 1 | 4.5 | 0.4 | 12.8 | | |

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Table 2 Material properties of simulated structures.

the direction of propagation of the electromagnetic waves. Plane waves were incident on the unit cell, and the transmission spectrum was monitored with a power monitor placed above the structure. Meanwhile, frequency profile monitors were used to detect the electric and magnetic fields.

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3. Results and Discussion

Because the T-SRR structure is symmetrical, the transmission is the same for both TE and TM polarizations. The simulated transmission spectra of T-SRR01 and T-SRR02 are shown in Figs. 2(a) and 2(b), respectively. The three resonant frequencies of T-SRR01 and T-SRR02 are referred as T-SRR01-1, T-SRR01-2, T-SRR01-3, and T-SRR02-1, T-SRR02-2, T-SRR02-3, respectively. The T-SRR01-2 has very sharp peaks referred as Fano resonance, which has a fixed frequency of 1.8000 THz. O angles are varied from 10 to 2 degrees. (The relative spectral width $\Delta f/f_{\rm res}$ with Δf , the spectral width at half maximum of the absorbance spectra, are presented in Table 3). The resonant frequency ranges for T-SRR01 and T-SRR02 resonator arrays have a redshift when the deformation angle decreases from 10 to 0 degrees. As we can see, the resonant frequencies of T-SRR02 arrays have a slight redshift compared with T-SRR01 resonator arrays, which may result from the different edge shapes of the "T" cantilevers.

To investigate the tunability of the released T-SRR01 and T-SRR02, the dependence of the resonance frequency on the angle O between the silicon and the cantilever is plotted in Fig. 3. As shown in Fig. 3, for the first resonant frequency of T-SRR01 and T-SRR02, the frequency of T-SRR01-1 decreases from 0.78667 to 0.61006 THz, while the frequency decreases from 0.71765 to 0.5451 THz for T-SRR02-1 when the angle O decreases from 10 to 0 degrees. For the second resonance, the frequencies of T-SRR01-2 and T-SRR02-2 decrease from 1.7956 to 1.6778 THz and from 1.7814 to 1.4931 THz, respectively, as the angle O is also decreased from 10 to 0 degrees. For the third resonance, the frequencies of T-SRR01-3 and T-SRR02-3 decrease from 2.0981 to 1.6778 THz and from 1.8709 to 1.8605 THz, respectively, as the angle O is decreased from 10 to 2 and 10 to 0 degrees, respectively. By comparing the tunable range of the resonance frequencies of these two resonators, it is found that T-SRR02-2 has a larger tunable range of 0.2883 THz for the second resonance, while T-SRR01-3 has the larger tunable range of 0.2981 THz for the third resonance.

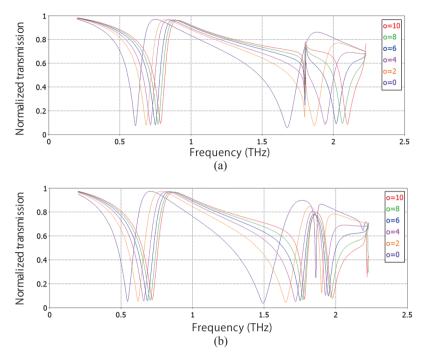


Fig. 2. (Color online) Simulated transmission spectra of (a) T-SRR01 and (b) T-SRR02 arrays with an incident THz wave.

Table 3
Relative spectral width of T-SRR01-2 absorbance spectra.

| Angle O | 2° | 4° | 6° | 8° | 10° |
|---------|-------|-------|-------|-------|-------|
| TE/TM | 0.012 | 0.009 | 0.006 | 0.005 | 0.005 |

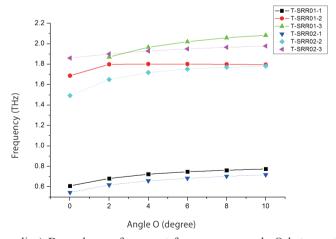


Fig. 3. (Color online) Dependence of resonant frequency on angle O between the silicon and the cantilever. The solid and dotted lines represent the resonance frequencies for T-SRR01 and T-SRR02, respectively.

To further investigate this resonance mode, FDTD simulations were performed to calculate the electric and magnetic field strength distributions at the resonance frequencies. Electric and magnetic field strength distributions corresponding to the resonance frequencies in Figs. 2(a) and 2(b) are shown in Figs. 4(a)–4(e) and 5(a)–5(f),

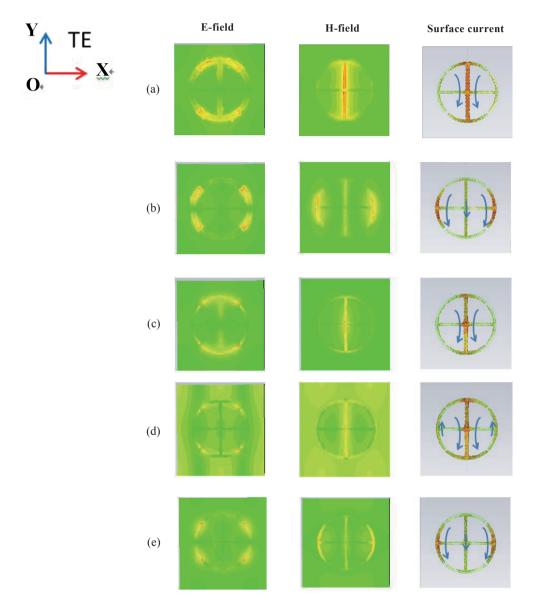


Fig. 4. (Color online) The calculated electric and magnetic field distributions and the surface current of the resonances in Fig. 2(a) are shown for (a) T-SRR01-1 (0.61006 THz), (b) T-SRR01-2 ($O = 0^{\circ}$) (1.6778 THz), (c) T-SRR01-1 (0.78667 THz), (d) T-SRR01-2 (1.7956 THz), and (e) T-SRR01-3 ($O = 10^{\circ}$) (2.0981 THz).

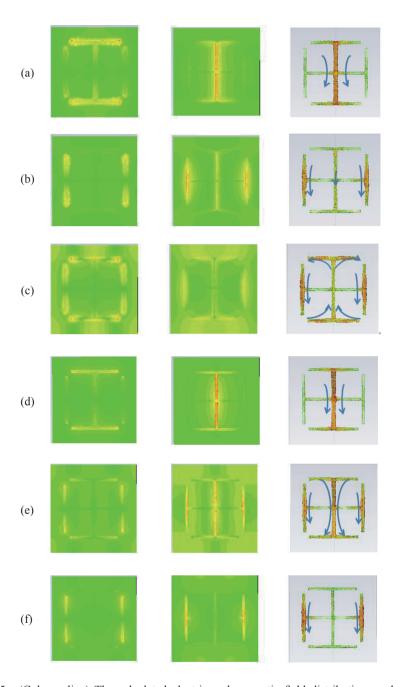


Fig. 5. (Color online) The calculated electric and magnetic field distributions and the surface current of the resonances in Fig. 2(b) are shown for (a) T-SRR02-1 (0.5451 THz), (b) T-SRR02-2 (1.4931 THz), (c) T-SRR02-3 ($O = 0^{\circ}$) (1.8605 THz), (d) T-SRR02-1 (0.71765 THz), (e) T-SRR02-2 (1.7814 THz), and (f) T-SRR02-3 ($O = 10^{\circ}$) (1.9783 THz).

respectively. For the first resonant frequency of T-SRR01, the charges accumulate strongly in the edge of the arc-shaped "T" cantilevers inducing harmonic current along the *y*-axis. The magnetic field strength is primarily distributed along the cantilevers parallel to the incident electric field, indicating dipole-type resonance, when the angle O is 0 degree. Similar phenomena were also observed at 10 degrees. For the second resonance of T-SRR01, there is electric and magnetic field coupling among units producing antiparallel currents parallel to the incident electric field. Therefore, the T-SRR01-2 with a fixed frequency of 1.8000 THz is obtained when the angle O changes from 10 to 2 degrees. For the third resonance of T-SRR01, the charges are strongly concentrated at the ends of the arc-shaped "T" cantilevers in the *x*-direction rather than being concentrated in the edge of "T" cantilevers in the *y*-direction. The magnetic fields are strongly concentrated on the edges of the arc-shaped "T" cantilevers in the *x*-direction and the cantilever in the direction of the incident electric field, inducing parallel currents.

A similar phenomenon was also observed for the T-SRR02 structure. However, for the second resonance of T-SRR02, T-SRR02-2 has a stronger electric field-to-magnetic field coupling among units than T-SRR01-2, producing strongly parallel currents, which result in the larger tuning range of T-SRR02-2. Because it includes weaker currents than T-SRR01-3, T-SRR02-3 has a smaller tunable range.

These plasmonic modes are excited because of the nonnegligible spatial extension of the structure in comparison with the wavelength. The effective size of the structure increases as the cantilever bends down toward the substrate. Hence, the resonance frequency decreases as the cantilever bends downward. (25) All the resonance ranges for T-SRR01 and T-RR02 resonator arrays have a red shift.

4. Conclusions

In summary, multiband MEMS-based metamaterial structures with polarization-independent transmission behavior have been designed. When the angle O between the silicon and the cantilever is varied, two types of T-SRR exhibit tunable multiband transmission characteristics in the range from 0.5000 to 2.5000 THz. All the resonances for the T-SRR arrays have a redshift when the deformation angle O of the 10 to 0 cantilevers under thermal actuation decreases. Moreover, the resonant frequencies of T-SRR02 resonator arrays have a slight redshift compared with those of T-SRR01 resonator arrays. In the electric and magnetic field strength distributions at the resonance frequencies, the edge shape of the "T" cantilevers plays an important role in transmission characteristics. The observed tunable multiband and polarization-independent properties may be desirable for potential applications in the development of THz devices. Furthermore, the approach presented here is not limited to THz frequencies but can be readily extended over the entire electromagnetic spectrum.

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